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June 2015

Common Drain N-Channel 2.5 V PowerTrench<sup>®</sup> WL-CSP MOSFET

## 24 V, 7 A, 23 mΩ

#### Features

- Max  $r_{S1S2(on)}$  = 23 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>S1S2</sub> = 1 A
- Max  $r_{S1S2(on)} = 25 \text{ m}\Omega$  at  $V_{GS} = 4 \text{ V}$ ,  $I_{S1S2} = 1 \text{ A}$
- Max  $r_{S1S2(on)}$  = 28 m $\Omega$  at V<sub>GS</sub> = 3.1 V, I<sub>S1S2</sub> = 1 A
- Max  $r_{S1S2(on)}$  = 33 m $\Omega$  at  $V_{GS}$  = 2.5 V,  $I_{S1S2}$  = 1 A
- Occupies only 2.2 mm<sup>2</sup> of PCB area
- Ultra-thin package: less than 0.35 mm height when mounted to PCB
- High power and current handling capability
- HBM ESD protection level > 3.2 kV (Note 3)
- RoHS Compliant

## **General Description**

This device is designed specifically as a single package solution for Li-lon battery pack protection circuit and other ultra-portable applications. It features two common drain N-channel MOSFETs, which enables bidirectional current flow, on Fairchild's advanced PowerTrench<sup>®</sup> process with state of the art "low pitch" WLCSP packaging process, the FDZ1416NZ minimizes both PCB space and  $r_{S1S2(on)}$ . This advanced WLCSP MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, ultra-low profile packaging, low gate charge and low  $r_{S1S2(on)}$ .

### **Applications**

- Battery management
- Load switch
- Battery protection



WL-CSP 1.4X1.6

## **MOSFET Maximum Ratings** $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>S1S2</sub>	Source1 to Source2 Voltage			24	V
V <sub>GS</sub>	Gate to Source Voltage			±12	V
I <sub>S1S2</sub>	Source1 to Source2 Current -Contin	nuous T <sub>A</sub> = 25°C	(Note 1a)	7	•
	-Pulsed			30	A
P <sub>D</sub>	Power Dissipation	$T_A = 25^{\circ}C$	(Note 1a)	1.7	14/
	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1b)	0.5	vv
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	74	°C/M
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	230	C/W

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
EN	FDZ1416NZ	WL-CSP 1.4X1.6	7 "	8 mm	5000 units

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	Test Conditions	Min	Тур	Max	Units	
cteristics						
Zero Gate Voltage Source1 to Source2 Current	V <sub>S1S2</sub> = 19 V, V <sub>GS</sub> = 0 V			1	μA	
Gate to Source Leakage Current	$V_{GS} = \pm 12 \text{ V}, V_{S1S2} = 0 \text{ V}$			±10	μA	
cteristics						
Gate to Source Threshold Voltage	$V_{GS} = V_{S1S2}, I_{S1S2} = 250 \ \mu A$	0.4	0.9	1.3	V	
	V <sub>GS</sub> = 4.5 V, I <sub>S1S2</sub> = 1 A	9	16	23	mΩ	
	V <sub>GS</sub> = 4 V, I <sub>S1S2</sub> = 1 A	10	17	25		
Static Source1 to Source2 On Resistance	V <sub>GS</sub> = 3.1 V, I <sub>S1S2</sub> = 1 A	11	19	28		
	V <sub>GS</sub> = 2.5 V, I <sub>S1S2</sub> = 1 A	12 22		33		
	V <sub>GS</sub> = 4.5 V, I <sub>S1S2</sub> = 1 A,T <sub>J</sub> = 125 <sup>o</sup> C		24	36		
Forward Transconductance	V <sub>S1S2</sub> = 5 V, I <sub>S1S2</sub> = 1 A		4.5		S	
Input Capacitance	V <sub>S1S2</sub> = 12 V, V <sub>GS</sub> = 0 V, f = 1 MHz		1140	1515	pF	
			1140	1515	p⊦	
Povereo Transfer Consoitaneo			130	220	pF	
Characteristics	· · · · · ·					
Turn-On Delay Time	$V_{\text{S1S2}} = 12 \text{ V}, \text{ I}_{\text{S1S2}} = 1 \text{ A}, \\ V_{\text{GS}} = 4.5 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$		9.5	19	ns	
Rise Time			12	22	ns	
Turn-Off Delay Time			37	59	ns	
Fall Time			16	33	ns	
Total Gate Charge	$V_{e1e2} = 12 V_{e1e2} = 1 A_{e1e2}$		12	17	nC	
Gate to Source1 Gate Charge	$V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$		1.6		nC	
Gate to Source2 "Miller" Charge			3.7		nC	
o Source2 Diode Characteristics			1			
	Diode Forward Current			1	А	
Maximum Continuous Source1 to Source2						
	Gate to Source Leakage Current Cteristics Gate to Source Threshold Voltage Static Source1 to Source2 On Resistance Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source1 Gate Charge Gate to Source2 "Miller" Charge	Gate to Source Leakage Current $V_{GS} = \pm 12 \text{ V}, \text{ V}_{S1S2} = 0 \text{ V}$ CateristicsGate to Source Threshold Voltage $V_{GS} = V_{S1S2}, I_{S1S2} = 250 \mu\text{A}$ Static Source1 to Source2 On Resistance $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 3.1 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 2.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{S1S2} = 5 \text{ V}, I_{S1S2} = 1 \text{ A}$ CharacteristicsInput Capacitance $V_{S1S2} = 12 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ CharacteristicsTurn-On Delay Time $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A}, V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$ Fall TimeTotal Gate Charge $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A}, V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$ Gate to Source1 Gate Charge $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A}, V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$	Gate to Source Leakage Current $V_{GS} = \pm 12 \text{ V}, V_{S1S2} = 0 \text{ V}$ CateristicsGate to Source Threshold Voltage $V_{GS} = V_{S1S2}, I_{S1S2} = 250 \ \mu\text{A}$ 0.4Static Source 1 to Source 2 On Resistance $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ 9 $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ 10 $V_{GS} = 2.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ 11 $V_{GS} = 2.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ 12 $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}, T_J = 125 \text{ °C}$ Forward Transconductance $V_{S1S2} = 5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ 12 $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}$ 12 $V_{GS} = 4.5 \text{ V}, I_{S1S2} = 1 \text{ A}, T_J = 125 \text{ °C}$ Forward Transconductance $V_{S1S2} = 5 \text{ V}, I_{S1S2} = 1 \text{ A}$ $V_{Duput Capacitance}$ $V_{S1S2} = 12 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ $P_{S1S2} = 12 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ $P_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{G1S1} = 10 \text{ Delay Time}$ $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{G1S1} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$ $Fall Time$ $V_{S1S2} = 12 \text{ V}, I_{S1S2} = 1 \text{ A},$ $V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$ $V_{G1S1} = 4.5 \text{ V}, V_{G2S2} = 0 \text{ V}$	$\begin{tabular}{ c c c c c } \hline Static Source Leakage Current & V_{GS} = \pm 12 \ V, \ V_{S1S2} = 0 \ V \\ \hline Static Source Threshold Voltage & V_{GS} = V_{S1S2}, \ I_{S1S2} = 250 \ \mu A & 0.4 & 0.9 \\ \hline Static Source 1 to Source 2 \ On Resistance & V_{GS} = 4.5 \ V, \ I_{S1S2} = 1 \ A & 10 & 17 \\ \hline V_{GS} = 4 \ V, \ I_{S1S2} = 1 \ A & 10 & 17 \\ \hline V_{GS} = 4 \ V, \ I_{S1S2} = 1 \ A & 10 & 17 \\ \hline V_{GS} = 3.1 \ V, \ I_{S1S2} = 1 \ A & 10 & 17 \\ \hline V_{GS} = 3.1 \ V, \ I_{S1S2} = 1 \ A & 10 & 17 \\ \hline V_{GS} = 2.5 \ V, \ I_{S1S2} = 1 \ A & 11 & 19 \\ \hline V_{GS} = 2.5 \ V, \ I_{S1S2} = 1 \ A & 12 & 22 \\ \hline V_{GS} = 4.5 \ V, \ I_{S1S2} = 1 \ A, \ T_J = 125 \ ^{\circ}C & 24 \\ \hline Forward Transconductance & V_{S1S2} = 5 \ V, \ I_{S1S2} = 1 \ A & 4.5 \\ \hline \end{tabular}$	$\begin{tabular}{ c c c c c c } \hline Content of the second system of the s$	



a. 74 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

 b. 230 °C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 us, Duty cycle < 2.0%.

3. The diode connected between the gate and source serves only protection against ESD. No gate overvoltage rating is implied.

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FDZ1416NZ Common Drain N-Channel 2.5 V PowerTrench<sup>®</sup> WL-CSP MOSFET





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